Search Notes



Text search in EAST (see search history)

Consulted with Yuwen Pan, Wen Huang

PLUS search

Application	/Control	No
-------------	----------	----

10572725

Reexamination
HAN ET AL.

Applicant(s)/Patent Under

572725

Examiner

Art Unit

Hsieh, Ping Y

2618

SEARCHED

Class	Subclass	Date	Examiner
455	76, 85, 86, 87, 118, 147, 148, 165.1, 183.1, 323, 324	9/7/10	PH

SEARCH NOTES		
Search Notes	Date	Examiner
earch history)	9/7/10	PH
	1/28/08	PH

11/12/08

PH

	INTERFERENCE SEA	RCH	
Class	Subclass	Date	Examiner

/P. Y. H./ Examiner.Art Unit 2618	

U.S. Patent and Trademark Office Part of Paper No.: 20100907